

SiGe bipolar junction transistors for microwave power applications

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High-efficiency silicon germanium (SiGe) bipolar junction transistors have been developed for 5-10 V, 1.88 GHz power amplifier applications. Class A-B biased common base parts have demonstrated a power gain $G_{\text{sub } p}=16$ dB, one-dB compression point $P_{\text{sub } 1\text{dB}}=25$ dBm and power-added-efficiency $\text{PAE}(P_{\text{sub } 1\text{dB}})=53\%$ at $V_{\text{sub } c}=5$ V and >1 W output power with >15 dB gain and $>50\%$ PAE at $V_{\text{sub } c}=10$ V. Common-emitter measurements ($V_{\text{sub } c}=7$ V) have demonstrated an output power of 28 dBm with greater than 60% collector efficiency. Under two-tone operation, the devices have achieved an output power of 23 dBm with 37% PAE at a third-order-intermodulation distortion of $\text{IM3}=30$ dBc. These results represent a significant improvement over conventional Si BJT's.

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